Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,611	DEHNE ET AL.	
Examiner	Art Unit	
Mark A. Deuble	3651	

SEARCHED				
Class	Subclass	Date	Examiner	
198	463.1			
104	287			
104	288			
213	76			
180	14.1			
29	791			
	799	12/20/2005		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY	)
	DATE	EXMR
see EAST search notes	12/20/2005	MD
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